January 2000

FDS6912

SEMICONDUCTOR IM

Dual N-Channel Logic Level PWM Optimized PowerTrench[®] MOSFET

General Description

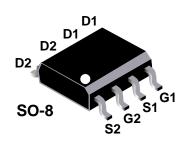
These N-Channel Logic Level MOSFETs have been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers.

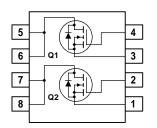
These MOSFETs feature faster switching and lower gate charge than other MOSFETs with comparable RDS(ON) specifications.

The result is a MOSFET that is easy and safer to drive (even at very high frequencies), and DC/DC power supply designs with higher overall efficiency.

Features

- 6 A, 30 V.
 $$\begin{split} R_{DS(ON)} &= 0.028 \ \Omega \ @ \ V_{GS} = 10 \ V \\ R_{DS(ON)} &= 0.042 \ \Omega \ @ \ V_{GS} = 4.5 \ V. \end{split}$$
- Optimized for use in switching DC/DC converters
 with PWM controllers
- Very fast switching.
- Low gate charge





Absolute Maximum Ratings T_A=25°C unless otherwise noted

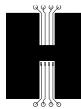
Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		30	V
V _{GSS}	Gate-Source Voltage		±20	V
ID	Drain Current – Continuous	(Note 1a)	6	A
	- Pulsed		20	
PD	Power Dissipation for Dual Operation		2	W
	Power Dissipation for Single Operation	(Note 1a)	1.6	
		(Note 1b)	1	
		(Note 1c)	0.9	
T _J , T _{stg}	Operating and Storage Junction Temperature Range		-55 to +150	°C
Therma	I Characteristics			
R _{θJA}	Thermal Resistance, Junction-to-Ambient	(Note 1a)	78	°C/W
R _{0JC}	Thermal Resistance, Junction-to-Case	(Note 1)	40	°C/W

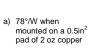
Package Marking and Ordering Information

-	Device Marking	Device	Reel Size	Tape width	Quantity
	FDS6912	FDS6912	13"	12mm	2500 units

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Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	racteristics					
BV _{DSS}	Drain–Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = 250 \mu\text{A}$	30			V
ΔBV_{DSS} ΔT_J	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$, Referenced to 25°C		20		mV/°C
DSS	Zero Gate Voltage Drain Current	$ \begin{array}{ll} V_{\text{DS}} = 24 \text{ V}, & V_{\text{GS}} = 0 \text{ V} \\ & T_{\text{J}} = 55^{\circ}\text{C} \end{array} $			1 10	μA
GSSF	Gate-Body Leakage, Forward	$V_{\text{GS}} = 20 \text{ V}, \qquad V_{\text{DS}} = 0 \text{ V}$			100	nA
GSSR	Gate–Body Leakage, Reverse	$V_{GS} = -20 \text{ V} \qquad V_{DS} = 0 \text{ V}$			-100	nA
On Char	acteristics (Note 2)					
V _{GS(th)}	Gate Threshold Voltage	$V_{\text{DS}} = V_{\text{GS}}, I_{\text{D}} = 250 \ \mu\text{A}$	1	2	3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$, Referenced to 25°C		-5		mV/°C
R _{DS(on)}	Static Drain–Source On–Resistance	$V_{GS} = 10 \text{ V}, \qquad I_D = 6 \text{ A}$		0.024 0.034	0.028	Ω
	On-Resistance	$T_J = 125^{\circ}C$ $V_{GS} = 4.5 \text{ V}, \qquad I_D = 4.9 \text{ A}$		0.034	0.048	
I _{D(on)}	On–State Drain Current	$V_{GS} = 10 \text{ V}, V_{DS} = 5 \text{ V}$	20			А
g _{FS}	Forward Transconductance	$V_{DS} = 10 V$, $I_D = 6 A$		20		S
- Dynami	c Characteristics					
	Input Capacitance	$V_{DS} = 15 V$, $V_{GS} = 0 V$,		740		pF
C _{oss}	Output Capacitance	f = 1.0 MHz		170		pF
C _{rss}	Reverse Transfer Capacitance	-		75		pF
Switchir	ng Characteristics (Note 2)		1			
t _{d(on)}	Turn–On Delay Time	$V_{DD} = 15 V$, $I_D = 1 A$,		8	16	ns
t _r	Turn–On Rise Time	$V_{GS} = 10 \text{ V}, \qquad R_{GEN} = 6 \Omega$		13	24	ns
t _{d(off)}	Turn–Off Delay Time	-		18	29	ns
t _f	Turn–Off Fall Time	-		8	16	ns
Qg	Total Gate Charge	$V_{DS} = 10 \text{ V}, \qquad I_D = 6 \text{ A},$		7	10	nC
Q _{gs}	Gate–Source Charge	$V_{GS} = 5 V$		3.8		nC
Q _{gd}	Gate-Drain Charge	-		2.5		nC
Drain-S	ource Diode Characteristics	and Maximum Ratings		•		
ls	Maximum Continuous Drain–Source				1.3	А
	Drain–Source Diode Forward	$V_{GS} = 0 V$, $I_S = 1.3 A$ (Note 2)		0.75	1.2	V









c) 135°/W when mounted on a minimum mounting pad.

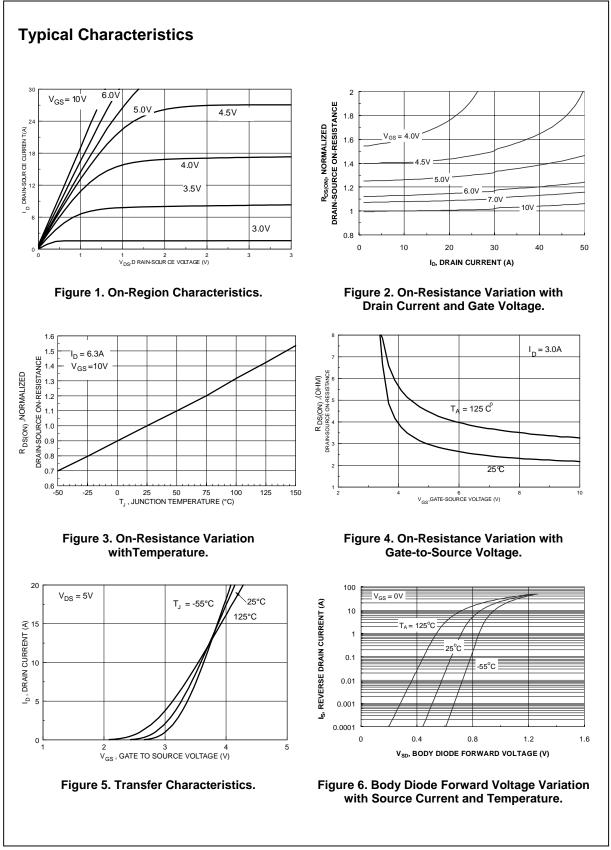
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Scale 1 : 1 on letter size paper

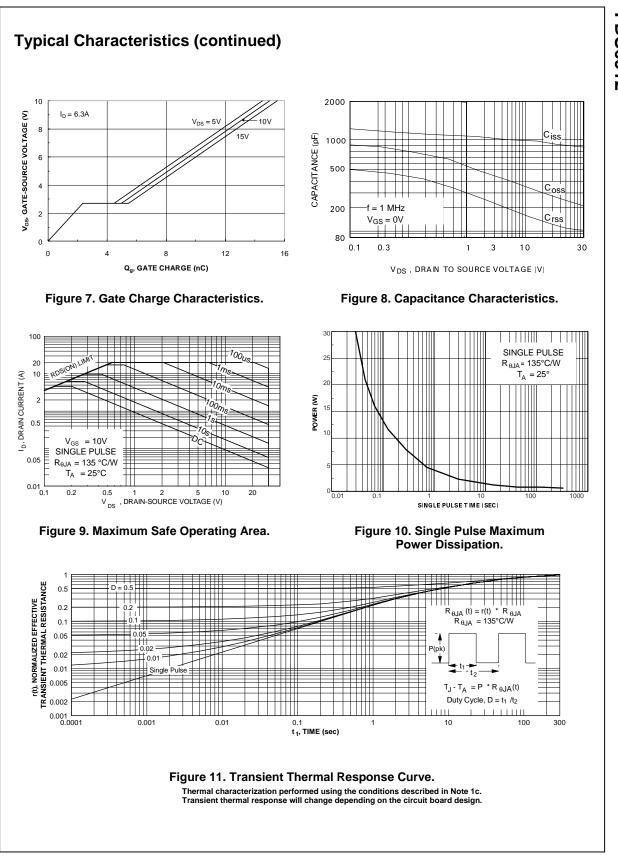
2. Pulse Test: Pulse Width <  $300\mu$ s, Duty Cycle < 2.0%

FDS6912 Rev E (W)

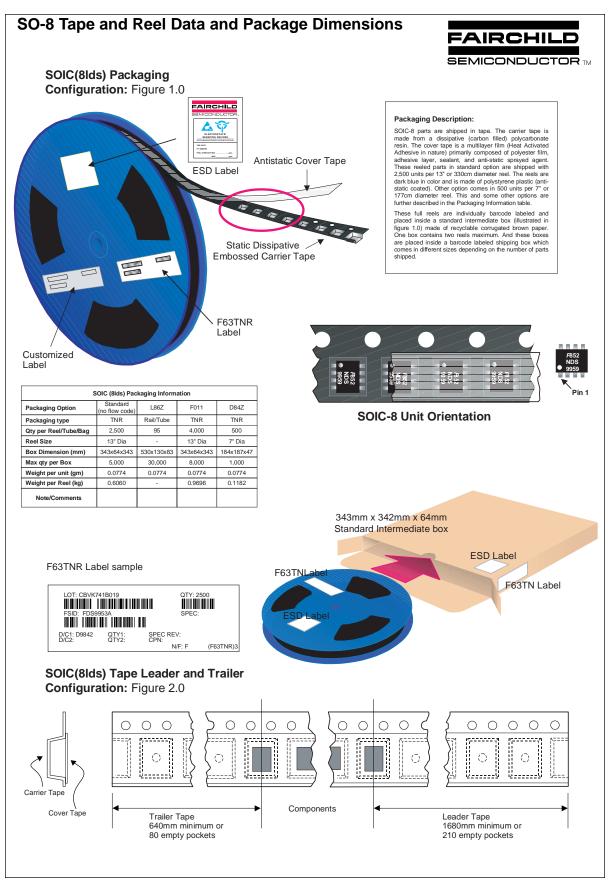
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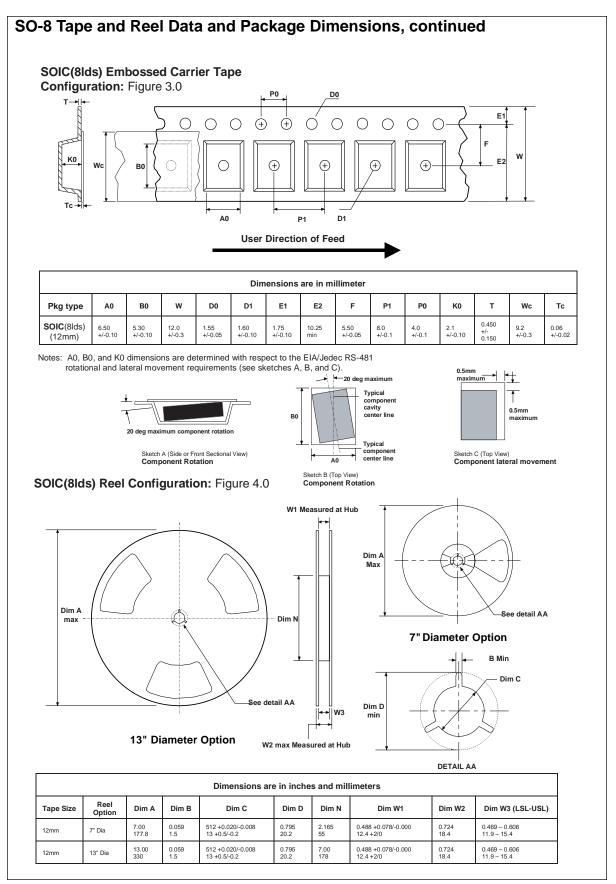
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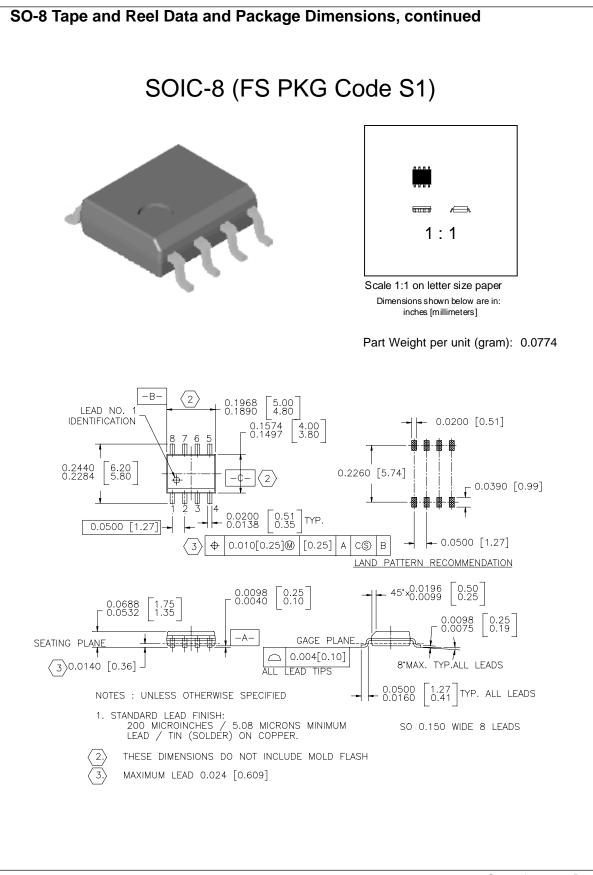


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July 1999, Rev. B





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**Definition of Terms** 

| Datasheet Identification | Product Status            | Definition                                                                                                                                                                                                                        |
|--------------------------|---------------------------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
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